







**TPS22997** 

SLVSGT0 - DECEMBER 2022

## TPS22997 5.5-V, 10-A, 4-mΩ On-Resistance Load Switch with Adjustable Rise Time

#### 1 Features

- Input operating voltage range (V<sub>IN</sub>): 0.1 V–5.5 V
- Bias voltage range: 1.5 V-5.5 V
- Maximum continuous current: 10 A
- ON-Resistance ( $R_{ON}$ ): 4 m $\Omega$  (typ.)
- Adjustable slew rate control
- Adjustable quick output discharge (QOD)
- Open drain Power Good (PG) signal
- Thermal shutdown
- Low power consumption:
  - ON state (I<sub>Q</sub>): 10 μA (typ.)
  - OFF state (I<sub>SD</sub>): 0.1 μA (typ.)
- Thermal shutdown
- Smart ON pin pulldown (R<sub>PD ON</sub>)
  - ON ≥  $V_{IH}$  ( $I_{ON}$ ): 25 nA (typ.)
  - ON ≤  $V_{IL}$  ( $R_{PD.ON}$ ): 500 kΩ (typ.)

## 2 Applications

- Solid state drive
- PC and notebooks
- **Industrial PC**
- Optical module

# VIN TUOV IS VBIAS D DOD X

**TPS22997 Block Diagram** 

#### 3 Description

The TPS22997 is a single-channel load switch that provides a configurable rise time to minimize inrush current. The device contains an N-channel MOSFET that can operate over an input voltage range of 0.1 V to 5.5 V and can support a maximum continuous current of 10 A.

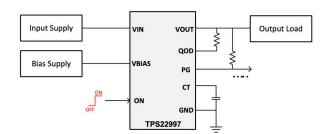
The switch is controlled by an enable pin (ON), which is capable of interfacing directly with low voltage GPIO signals ( $V_{IH}$  = 0.8 V). The TPS22997 device has an optional QOD pin for quick output discharge when switch is turned off, and the fall time (t<sub>FALL</sub>) of the output can be adjusted through an external resistor. There is a Power Good (PG) signal on the device that indicates when the main MOSFET is fully turned on, which can be used to enable a downstream load. Integrated thermal shutdown ensures protection in high temperature environments.

The TPS22997 is available in a 1.5 × 2.0 mm, 0.5 mm pitch, 10-pin WQFN package (RYZ) and is characterized for operation over the free-air temperature range of -40°C to +125°C.

#### **Device Information**

PART NUMBER		PACKAGE <sup>(1)</sup>	BODY SIZE (NOM)					
	TPS22997	WQFN (10)	1.5 × 2.0 mm					

For all available packages, see the orderable addendum at the end of the data sheet



**TPS22997 Typical Application** 



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**4 Revision History**NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
December 2022	*	Initial Release



## **5 Pin Configuration and Functions**

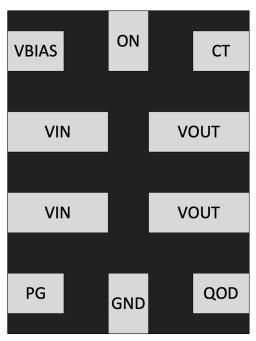


Figure 5-1. TPS22997 RYZ Package, 10-Pin WQFN (Top View)

**Table 5-1. Pin Functions** 

PIN		I/O <sup>(1)</sup>	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
VBIAS	1	I	Device bias supply	
VIN	2, 3	I	Switch input	
PG 4		0	Open drain power good signal, asserted high when the output is full load ready	
GND	5	-	Device ground	
QOD	6	-	Quick output discharge pin	
VOUT	VOUT 7, 8		Switch output	
CT 9		ı	Timing pin, can control the slew rate of the output through a capacitor to GND	
ON 10 I Enabl		I	Enable pin	

(1) I = Input, O = Output



#### **6 Specifications**

### **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
V <sub>IN</sub>	Input Voltage	-0.3	6	V
V <sub>BIAS</sub>	Bias Voltage	-0.3	6	V
$V_{ON}, V_{PG}, V_{QOD}$	Control Pin Voltage	-0.3	6	V
V <sub>CT</sub>	CT Pin Voltage		15	V
I <sub>MAX</sub>	Maximum Current		10	А
TJ	Junction temperature		Internally Limited	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatio discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins <sup>(1)</sup>	±2000	\/
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	±1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

#### **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
V <sub>IN</sub>	Input Voltage	0.1	5.5	V
V <sub>BIAS</sub>	Bias Voltage	1.5	5.5	V
V <sub>IH</sub>	ON Pin High Voltage Range	0.8	5.5	V
V <sub>IL</sub>	ON Pin Low Voltage Range	0	0.35	V
$V_{PG}, V_{QOD}$	Control Pin Voltage	0	5.5	V
T <sub>A</sub>	Ambient Temperature	-40	125	°C

#### **6.4 Thermal Information**

		TPS22997	
	THERMAL METRIC	RYZ (WQFN)	UNIT
		10 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	83.7	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	73.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	18.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	2.0	°C/W
$Y_{JB}$	Junction-to-board characterization parameter	18.1	°C/W

Product Folder Links: TPS22997

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 6.5 Electrical Characteristics (VBIAS = 5 V)

over operating free-air temperature range (unless otherwise noted). Typical values are specified at  $25^{\circ}$ C and VIN = 3.3V, VBIAS = 5.5V.

	PARAMETER	TEST CONDITIONS	T <sub>A</sub>	MIN	TYP	MAX	UNIT
Power Cons	umption						
			25°C		0.1		uA
I <sub>SD,VBIAS</sub>	VBIAS Shutdown Current	ON = 0V	-40°C to 85°C			0.5	uA
			-40°C to 125°C			1	uA
			25°C		10		uA
$I_{Q,VBIAS}$	VBIAS Quiescent Current	ON > V <sub>IH</sub>	-40°C to 85°C			15	uA
			-40°C to 125°C			15	uA
			25°C		0.1		uA
I <sub>SD,VIN</sub>	VIN Shutdown Current	ON = 0V	-40°C to 85°C			1	uA
			-40°C to 125°C			7	uA
I <sub>ON</sub>	ON pin leakage	ON = VBIAS	-40°C to 125°C		0.1		uA
Performance	e		-			'	
			25°C		4		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 5V	-40°C to 85°C			6	mΩ
			-40°C to 125°C	-		7	mΩ
	On-Resistance	VIN = 3.3V	25°C		4		mΩ
R <sub>ON</sub>			-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
	On-Resistance	VIN = 1.8V	25°C		4		mΩ
R <sub>ON</sub>			-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
			25°C		4		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 1.2V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	$m\Omega$
			25°C		4		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 0.8V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
$V_{OL,PG}$	Power Good VOL	I <sub>PG</sub> = 1mA	-40°C to 125°C			0.2	V
D	Smart Pull Down Resistance		25°C		500		kΩ
$R_{PD,ON}$	Omart Full Down Resistance		-40°C to 125°C			700	kΩ
	QOD Resistance		25°C		50		Ω
$R_{QOD}$			-40°C to 125°C			75	Ω
Protection							
TSD	Thermal Shutdown		-	150	170	190	°C
TSD <sub>HYS</sub>	Thermal Shutdown Hysteresis		-		20		°C

#### 6.6 Electrical Characteristics (VBIAS = 3.3 V)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>A</sub>	MIN	TYP	MAX	UNIT		
Power Consumption									
			25°C		0.1		uA		
I <sub>SD,VBIAS</sub>	VBIAS Shutdown Current	ON = 0V	-40°C to 85°C			0.5	uA		
			-40°C to 125°C			1	uA		



## 6.6 Electrical Characteristics (VBIAS = 3.3 V) (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>A</sub>	MIN	TYP	MAX	UNIT
			25°C		10		uA
$I_{Q,VBIAS}$	VBIAS Quiescent Current	ON > V <sub>IH</sub>	-40°C to 85°C			15	uA
			-40°C to 125°C		10	uA	
			25°C		0.1		uA
I <sub>SD,VIN</sub>	VIN Shutdown Current	ON = 0V	-40°C to 85°C			1	uA
			-40°C to 125°C			7	uA
I <sub>ON</sub>	ON pin leakage	ON = VBIAS	-40°C to 125°C		0.1		uA
Performanc	e	'					
			25°C		4		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 3.3V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
			25°C		4		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 1.8V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
	On-Resistance	VIN = 1.2V	25°C		4		mΩ
R <sub>ON</sub>			-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
			-40°C to 85°C  -40°C to 125°C  7  1  25°C  4  -40°C to 85°C  -40°C to 125°C  7  1  25°C  4  1  25°C  -40°C to 125°C  7  1  25°C  4  1  25°C  -40°C to 125°C  7  1  25°C  -40°C to 125°C  -40°C to 125°C	mΩ			
R <sub>ON</sub>	On-Resistance	VIN = 0.8V	-40°C to 85°C			15 15 0.1 1 7 0.1 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 4 6 7 1 1 1 1 1 1 1 1 1 1 1 1 1	mΩ
			-40°C to 125°C				mΩ
$V_{OL,PG}$	Power Good VOL	I <sub>PG</sub> = 1mA	-40°C to 125°C			0.2	V
В	Smart Pull Down Resistance		25°C		500		kΩ
$R_{PD,ON}$	Smart Pull Down Resistance		-40°C to 125°C			700	kΩ
D	QOD Resistance		25°C		50		Ω
$R_{QOD}$	QOD Resistance		-40°C to 125°C			100	Ω
Protection							
TSD	Thermal Shutdown		-	150	170	190	°C
TSD <sub>HYS</sub>	Thermal Shutdown Hysteresis		-		20		°C

## 6.7 Electrical Characteristics (VBIAS = 1.5 V)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>A</sub>	MIN	TYP	MAX	UNIT
Power Cons	umption	·					
			25°C		0.1		uA
I <sub>SD,VBIAS</sub>	VBIAS Shutdown Current	ON = 0V	-40°C to 85°C			0.5	uA
I <sub>Q,VBIAS</sub> I <sub>SD,VIN</sub>			-40°C to 125°C			1	uA
	VBIAS Quiescent Current		25°C		10		uA
$I_{Q,VBIAS}$		ON > V <sub>IH</sub>	-40°C to 85°C			15	uA
I <sub>Q,VBIAS</sub>			-40°C to 125°C			15	uA
			25°C		0.1		uA
I <sub>SD,VIN</sub>	VIN Shutdown Current	ON = 0V	-40°C to 85°C			1	uA
			-40°C to 125°C			7	uA
I <sub>ON</sub>	ON pin leakage	ON = VBIAS	-40°C to 125°C		0.1		uA
Performance	e						

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## 6.7 Electrical Characteristics (VBIAS = 1.5 V) (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>A</sub>	MIN	TYP	MAX	UNIT
			25°C		4.5		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 1.5V	-40°C to 85°C		,	6	mΩ
			-40°C to 125°C			7	mΩ
			25°C		4.5		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 1.2V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
			25°C		4.5		mΩ
R <sub>ON</sub>	On-Resistance	VIN = 0.8V	-40°C to 85°C			6	mΩ
			-40°C to 125°C			7	mΩ
V <sub>OL,PG</sub>	Power Good VOL	I <sub>PG</sub> = 1mA	-40°C to 125°C			0.2	V
Б	Conset Dull Davin Desistance		25°C		500		kΩ
R <sub>PD,ON</sub>	Smart Pull Down Resistance		-40°C to 125°C			700	kΩ
Б	OOD Desisteres		25°C		55		Ω
R <sub>QOD</sub>	QOD Resistance		-40°C to 125°C			100	Ω
Protection	·		, ,				
TSD	Thermal Shutdown		-	150	170	190	°C
TSD <sub>HYS</sub>	Thermal Shutdown Hysteresis		-		20		°C

#### **6.8 Switching Characteristics (VBIAS = 5 V)**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
VIN = 5	v	<u>'</u>			
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	1170		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	819		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	347		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	2090		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	108		us
VIN = 3.	.3V	<u>'</u>			
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	944		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	567		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	377		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	2110		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	113		us
VIN = 1.	.8V	<u>'</u>			
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	692		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	327		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	365		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	2150		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	117		us
VIN = 1.	.2V			·	
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	591		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	227		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	364		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$	2180		us



#### 6.8 Switching Characteristics (VBIAS = 5 V) (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
tOFF	Turn OFF time	R <sub>L</sub> = 100Ω, C <sub>L</sub> = 10uF, CT = 1000pF	120		us	
VIN = 0.8	V					
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF		523		us
tRISE	Rise time	R <sub>L</sub> = 100Ω, C <sub>L</sub> = 10uF, CT = 1000pF		159		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10$ uF, $CT = 1000$ pF		365		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10$ uF, $CT = 1000$ pF		2260		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10$ uF, $CT = 1000$ pF		129		us

## 6.9 Switching Characteristics (VBIAS = 3.3 V)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VIN = 3.	3V					
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		898		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		563		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		336		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		2100		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		108		us
VIN = 1.	8V					
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		708		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		331		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		377		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		2145		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		113		us
VIN = 1.	2V					
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		605		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		231		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		375		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		2190		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		119		us
VIN = 0.	8V		,	-		
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		536		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		162		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		373		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10uF$ , $CT = 1000pF$		2260		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF		126		us

## 6.10 Switching Characteristics (VBIAS = 1.5 V)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP N	ΙΑΧ	UNIT
VIN = 1.5	V					
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF		620		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF		281		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF		340		us

Product Folder Links: TPS22997



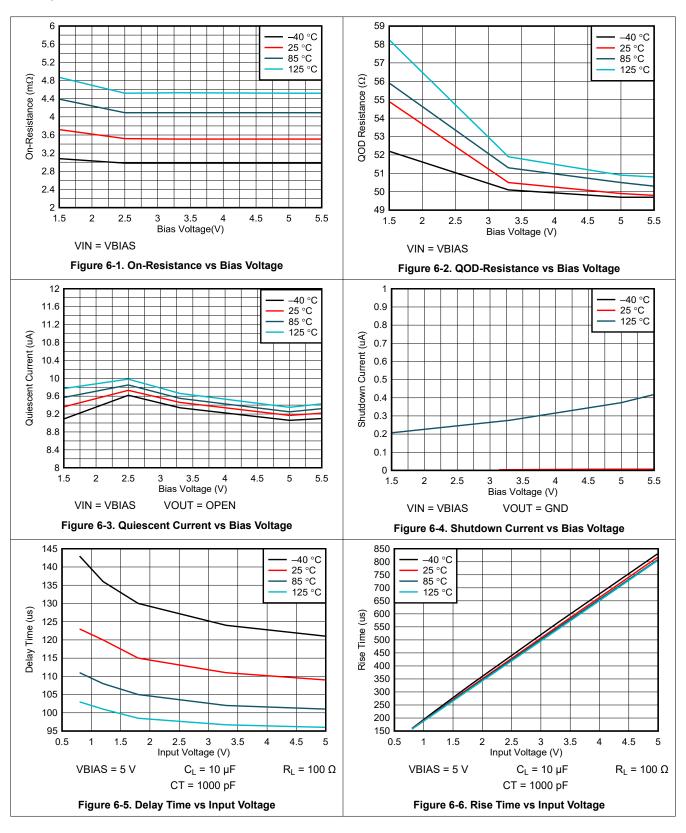
## 6.10 Switching Characteristics (VBIAS = 1.5 V) (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	2150		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	111		us
VIN = 1.	2V				
tON	Turn ON time	R <sub>L</sub> = 100Ω, C <sub>L</sub> = 10uF, CT = 1000pF	642		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10$ uF, $CT = 1000$ pF	237		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	404		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	2170		us
tOFF	Turn OFF time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	114		us
VIN = 0.	8V				
tON	Turn ON time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	535		us
tRISE	Rise time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	166		us
tD	Delay time	$R_L = 100\Omega$ , $C_L = 10$ uF, CT = 1000pF	368		us
tFALL	Fall time	$R_L = 100\Omega$ , $C_L = 10$ uF, $CT = 1000$ pF	2245		us
tOFF	Turn OFF time	R <sub>L</sub> = 100Ω, C <sub>L</sub> = 10uF, CT = 1000pF	171		us

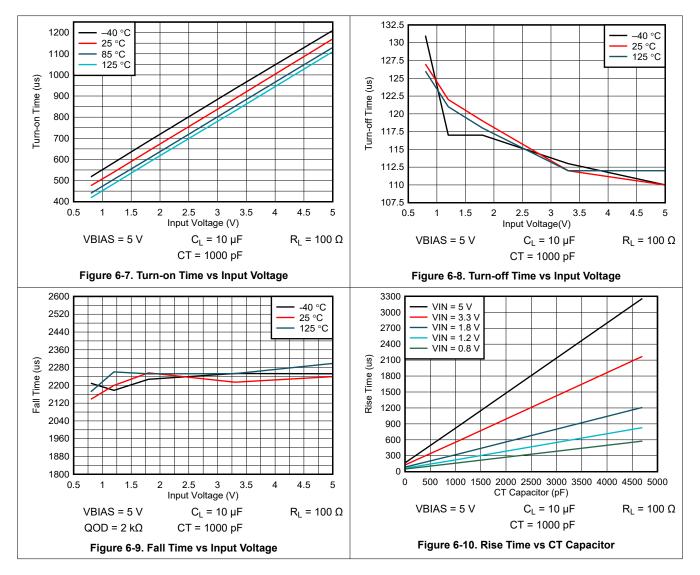


#### **6.11 Typical Characteristics**





## **6.11 Typical Characteristics (continued)**





## 7 Parameter Measurement Information

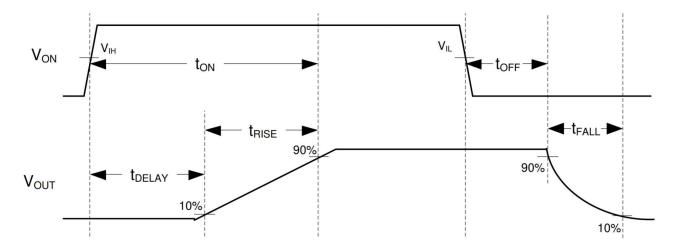


Figure 7-1. TPS22997 Timing Diagram



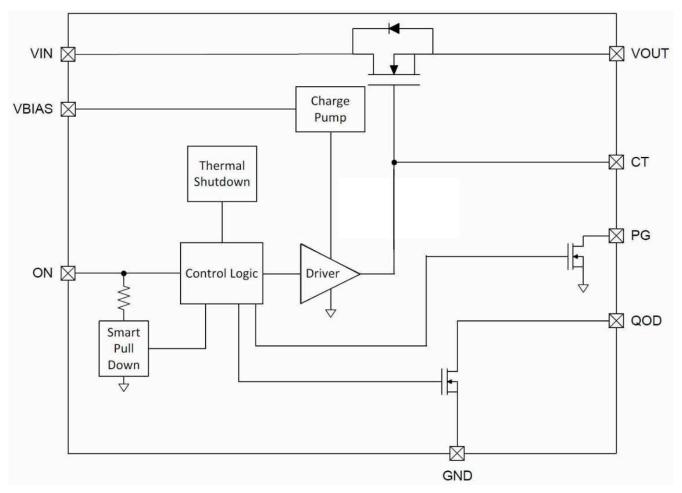
#### **8 Detailed Description**

#### 8.1 Overview

The TPS22997 device is a single-channel load switch with a 4-m $\Omega$  power MOSFET designed to operate up to 10 A. The voltage range is 0.1 V to 5.5 V. A configurable rise time provides flexibility for power sequencing and minimizes inrush current for high capacitance loads.

The switch is controlled by an enable pin (ON), which is capable of interfacing directly with low voltage GPIO signals down to its  $V_{IH}$  level of 0.8 V. The TPS22997 device has an optional QOD pin for quick output discharge when switch is turned off, and the fall time ( $t_{FALL}$ ) of the output can be adjusted through an external capacitor. There is a Power Good (PG) signal on the device that indicates when the main MOSFET is fully turned on and the on-resistance is at its final value.

## 8.2 Functional Block Diagram



#### 8.3 Feature Description

#### 8.3.1 ON and OFF Control

The ON pin controls the state of the switch. The ON pin is compatible with standard GPIO logic threshold so it can be used in a wide variety of applications. When the pin pull high, the device enables, and when it is low, the device disables.

#### 8.3.2 Adjustable Slew Rate

A capacitor to GND on the CT pin sets the slew rate, and the higher the capacitance the lower the slew rate. The voltage on the CT pin can be as high as 15 V; therefore, the minimum voltage rating for the CT capacitor must be 30 V for optimal performance. Rise times for VBIAS = 5 V are shown below.

CT Capacitor	VIN = 5 V	VIN = 3.3 V	VIN = 1.8 V	VIN = 1.2 V	VIN = 0.8 V
0 pF	165 µs	126 µs	86 µs	66 µs	51 µs
220 pF	309 µs	221 µs	137 µs	99 µs	74 µs
1000 pF	819 µs	554 µs	319 µs	222 µs	160 µs
4700 pF	3260 µs	2170 µs	1210 µs	829 µs	575 µs

The following equation can be used to estimate the rise time for different VIN and CT capacitors at VBIAS = 5 V.

$$t_R = (0.1302 V_{IN} + 0.0063) \times CT + 27.797 V_{IN} + 30.54$$
 (1)

#### Where:

- t<sub>R</sub> = Rise time in μs
- V<sub>IN</sub> = Input voltage in V
- CT = CT capacitance in pF

#### 8.3.3 Adjustable Quick Output Discharge

The TPS22997 device includes a QOD feature that can be configured in one of three ways:

- 1. QOD pin shorted to VOUT pin. Using this method, the discharge rate after the switch becomes disabled is controlled with the value of the internal resistance RQOD. The value of this resistance is listed in the Electrical Characteristics table.
- 2. QOD pin connected to VOUT pin using an external resistor R<sub>EXT</sub>. After the switch becomes disabled, the discharge rate is controlled by the value of the total resistance of the QOD.
- 3. QOD pin is unused and left floating. Using this method, there is no quick output discharge functionality, and the output remains floating after the switch is disabled.

Fall time is dependent on the strength of the configured pulldown resistance on the output.

#### 8.3.4 Thermal Shutdown

When the device temperature reaches 150°C (typical), the device shuts itself off to prevent thermal damage. After it cools off by about 20°C, the device turns back on. If the device is kept in a thermally stressful environment, then the device oscillates between these two states until it can keep its temperature below the thermal shutdown point.

#### 8.3.5 Power Good (PG) Signal

The TPS22997 device has a Power Good (PG) output signal to indicate the gate of the pass FET is driven high and the switch is on with the on-resistance close to its final value (full load ready). The signal is an active high and open drain output which can be connected to a voltage source through an external pullup resistor, R<sub>PU</sub>. This voltage source can be VOUT from the TPS22997 device or another external voltage. VBIAS is required for PG to have a valid output.

#### 8.4 Device Functional Modes

The below table summarizes the device functional modes:

ON	Fault Condition	VOUT State
L	N/A	Hi-Z
Н	None	V <sub>IN</sub> (through R <sub>ON</sub> )







ON **Fault Condition VOUT State** Χ Thermal shutdown Hi-Z

Product Folder Links: TPS22997



#### 9 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 9.1 Application Information

This section highlights some of the design considerations when implementing this device in various applications.

#### 9.2 Typical Application

This typical application demonstrates how to use the TPS22997 device to limit startup inrush current.

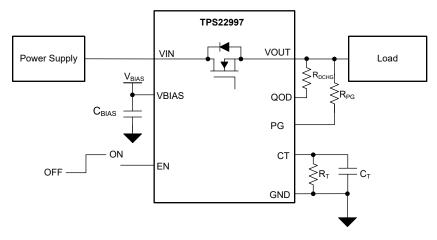


Figure 9-1. TPS22997 Basic Application

**Table 9-1. Component Descriptions** 

• • • • • • • • • • • • • • • • • • •	•
PARAMETER	Purpose
C <sub>BIAS</sub>	Stabilize the bias supply and filter out low frequency noise.
C <sub>T</sub>	Adjustable rise time capacitor.
R <sub>T</sub>	Optional $C_T$ capacitor discharge resistor for cases when device is disabled before output has fully ramped up. Use a resistor >10M $\Omega$ .
R <sub>DCHG</sub>	Adjustable output discharge resistor.

#### 9.2.1 Design Requirements

For this example, the values below are used as the design parameters.

**Table 9-2. Design Parameters** 

PARAMETER	VALUE
V <sub>BIAS</sub>	5.0 V
V <sub>IN</sub>	5.0 V
Load capacitance	220 μF
Maximum inrush current	1.5 A

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#### 9.2.2 Detailed Design Procedure

When the switch enables, the charge up the output capacitance from 0 V to the set value (1.8 V in this example). This charge arrives in the form of inrush current. Calculate inrush current using Equation 2.

Inrush Current = 
$$C_L \times dVOUT/dt$$
 (2)

#### Where:

- C<sub>L</sub> is the output capacitance.
- dVOUT is the change in VOUT during the ramp up of the output voltage when device is enabled. Because rise time is 10% of VOUT to 90% of VOUT, this is 80% of the VIN value.
- dt is the rise time in VOUT during the ramp up of the output voltage when the device is enabled.

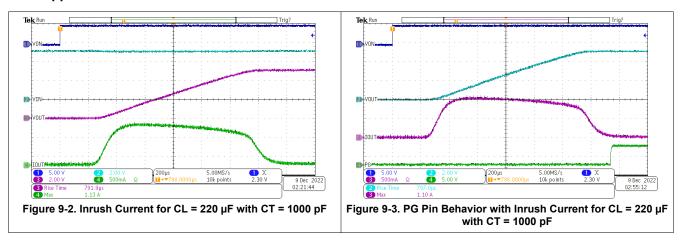
The TPS22997 offers an adjustable rise time for VOUT, allowing the user to control the inrush current during turn on. Calculate the appropriate rise time using the design requirements and the inrush current equation as shown below.

$$1.5 A = 220 \mu F \times (5.0 \text{ V} \times 80\%) / \text{ dt}$$
 (3)

$$dt = 586 \text{ us}$$
 (4)

To ensure an inrush current of less than 1.5 A, a  $C_T$  setting that yields a rise time of more than 586  $\mu$ s must be chosen. By using a 1000pF capacitance, a rise time of 819  $\mu$ s is selected, limiting the inrush current to below 1.5 A.

#### 9.2.3 Application Performance Plots



#### 9.3 Power Supply Recommendations

The TPS22997 device is designed to operate with a VIN range of 0.1 V to 5.5 V. Regulate the VIN power supply well. The power supply must be able to withstand all transient load current steps. In most situations, using an input capacitance ( $C_{IN}$ ) of 1  $\mu F$  is sufficient to prevent the supply voltage from dipping when the switch is turned on. In cases where the power supply is slow to respond to a large transient current or large load current step, additional bulk capacitance can be required on the input.

A capacitor ( $C_{BIAS}$ ) is recommended to be placed as close to the device as possible to stabilize the supply and filter our low frequency noise.



#### 9.4 Layout

#### 9.4.1 Layout Guidelines

For best performance, all traces must be as short as possible. To be most effective, place the input and output capacitors close to the device to minimize the effects that parasitic trace inductances can have on normal operation. Using wide traces for VIN, VOUT, and GND helps minimize the parasitic electrical effects.

#### 9.4.2 Layout Example

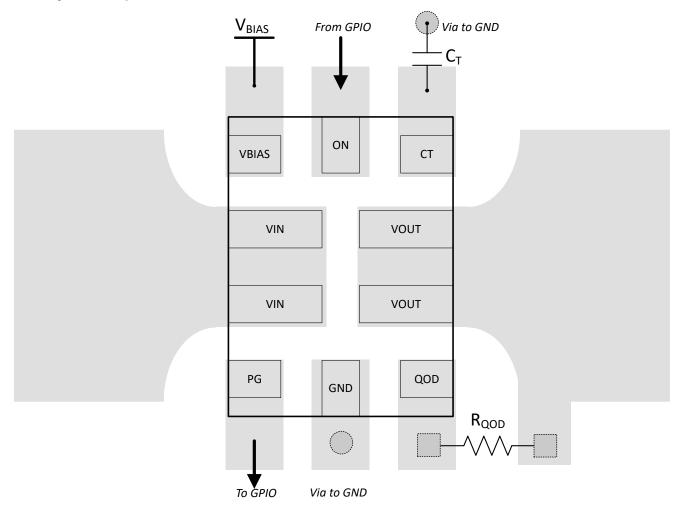


Figure 9-4. TPS22997 Layout Example



## 10 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

#### 10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 10.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.



## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
TPS22997RYZR	Active	Production	WQFN-HR (RYZ)   10	3000   LARGE T&R	Yes	Call TI   Sn   Nipdau	Level-2-260C-1 YEAR	-40 to 125	102
TPS22997RYZR.A	Active	Production	WQFN-HR (RYZ)   10	3000   LARGE T&R	Yes	Call TI	Level-2-260C-1 YEAR	-40 to 125	102

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

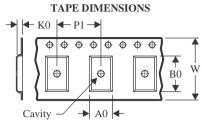
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

## **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

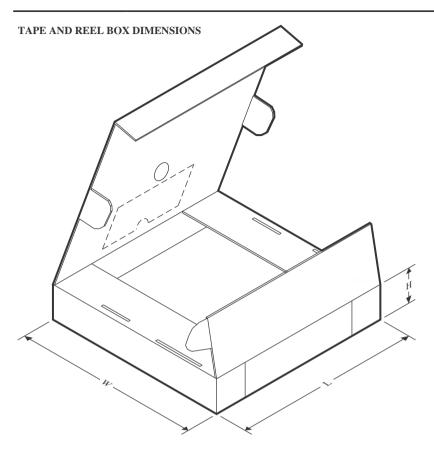


#### \*All dimensions are nominal

Γ	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	TPS22997RYZR	WQFN- HR	RYZ	10	3000	180.0	8.4	1.75	2.25	1.0	4.0	8.0	Q1

## **PACKAGE MATERIALS INFORMATION**

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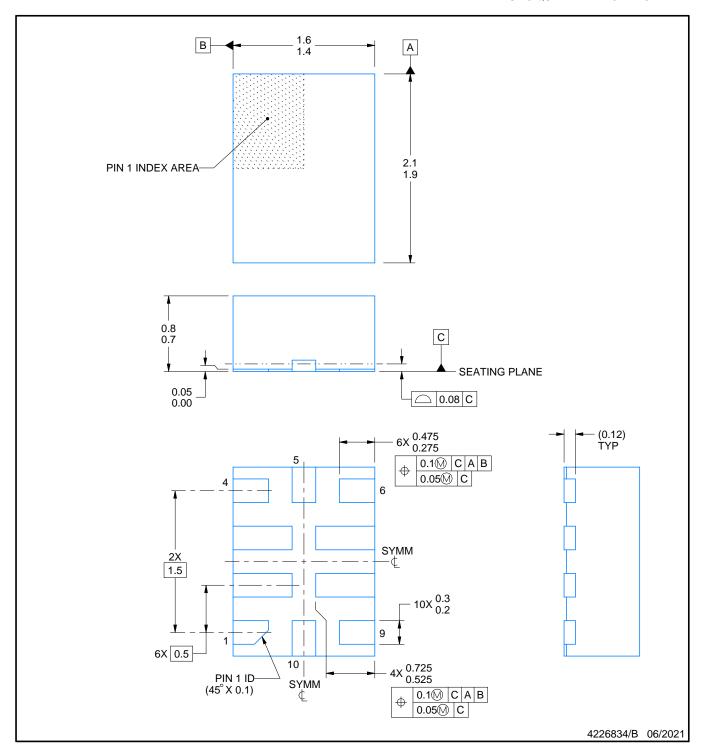


#### \*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
ı	TPS22997RYZR	WQFN-HR	RYZ	10	3000	210.0	185.0	35.0	



PLASTIC QUAD FLATPACK - NO LEAD

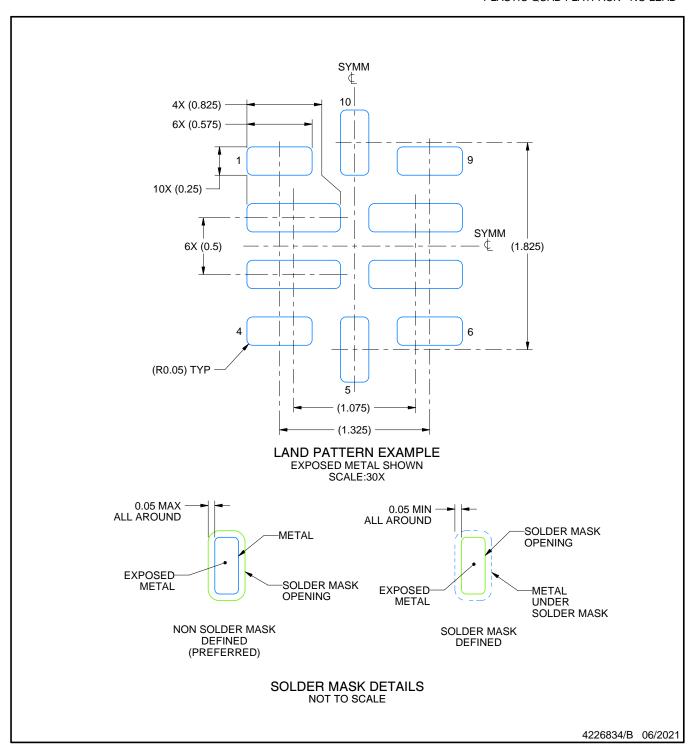


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



PLASTIC QUAD FLATPACK - NO LEAD

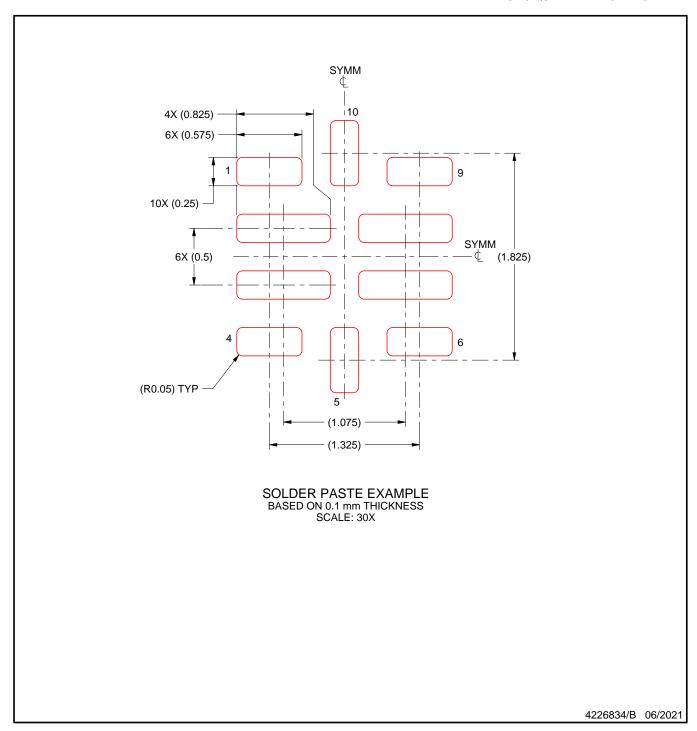


NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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